

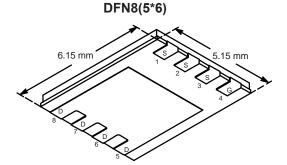
## **AON6405-VB** Datasheet

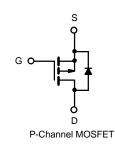
## P-Channel 30 V (D-S) MOSFET

PRODUC	PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) Max.	I <sub>D</sub> <sup>a</sup>	Q <sub>g</sub> (Typ.)			
	0.0080 at $V_{GS}$ = - 10 V	- 60				
- 30	0.0090 at V <sub>GS</sub> = - 6 V	- 53	66 nC			
	0.0120 at $V_{GS}$ = - 4.5 V	- 50				

#### **FEATURES**

- Extended  $V_{GS}$  range (± 25 V) for adaptor switch applications
- Extremely low R<sub>DS(on)</sub>
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>g</sub> and UIS Tested
- Typical ESD Performance: 4000 V (HBM)





Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V <sub>DS</sub>	- 30		
Gate-Source Voltage		V <sub>GS</sub>	± 20		
	T <sub>C</sub> = 25 °C		- 60		
Continuous Drain Current (T <sub>1</sub> = 150 °C)	T <sub>C</sub> = 70 °C		- 50.7		
Continuous Drain Current $(1) = 150$ C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 47.3		
	T <sub>A</sub> = 70 °C		- 43.9 <sup>b, c</sup>	Α	
Pulsed Drain Current (t = 300 µs)		I <sub>DM</sub>	- 150		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C		- 58 <sup>b, c</sup>		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	- I <sub>S</sub>	- 46 <sup>b, c</sup>		
Single Pulse Avalanche Current		I <sub>AS</sub>	- 40		
Single Pulse Avalanche Energy L = 0.1 mH		E <sub>AS</sub>	80		
	T <sub>C</sub> = 25 °C		75		
Maximum Rower Discinction	T <sub>C</sub> = 70 °C	P <sub>D</sub>	40	W	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C		3.1 <sup>b, c'</sup>	VV	
	T <sub>A</sub> = 70 °C		2 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stq</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RA	TINGS				
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	33	40	°C/W
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	15	17	0,11
Nataa					•

Notes:

a. Based on  $T_C = 25 \text{ °C}$ . b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s. d. Maximum under steady state conditions is 90 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static						1	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA	- 30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	1 050 04		- 24			
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = - 250 μA		6		mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = -250 \ \mu A$	- 1.0		- 2.5	V	
		$V_{DS} = 0 V, V_{GS} = \pm 25 V$			± 150	-	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 15	μΑ	
		V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V			- 1		
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le$ - 5 V, $V_{GS}$ = - 10 V	- 20			A	
		$\begin{array}{c c c c c c c c c c c c c c c c c c c $					
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 6 V, I <sub>D</sub> = - 10 A		0.0090	$\begin{array}{c c c c c c c } & \pm 15 & \\ & -1 & \\ & -10 & \\ \hline & & -10 & \\ \\ \hline & & -10 & \\ \\ & & -10 & \\ \\ & & & \\ \\ & & & \\ \\ \hline & & & \\ \\ \hline & & & \\ \hline \hline & & \\ \hline & & \\ \hline & & \\ \hline & & \\ \hline \hline & & \\ \hline & & \\ \hline \hline \hline \\ \hline \hline & & \\ \hline \hline \hline & & \\ \hline \hline \hline \hline$	Ω	
	- ( - )	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 8 A		0.0120			
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 13 A		44		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			4620			
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		880		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			820			
Takal Qada Olasana	0	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 17.3 A		102	153		
Total Gate Charge	Qg			66	80		
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 5 V, I <sub>D</sub> = - 17.3 A		16		nC	
Gate-Drain Charge	Q <sub>gd</sub>			28			
Gate Resistance	Rg	f = 1 MHz	0.3	1.3	2.6	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			70	105		
Rise Time	t <sub>r</sub>	$V_{DD} = 0 \text{ V}, \text{ R}_{L} = 1.5 \Omega$		70	105		
Turn-Off Delay Time	t <sub>d(off)</sub>	$\text{I}_\text{D}\cong$ - 10 A, $\text{V}_\text{GEN}$ = - 4.5 V, $\text{R}_\text{g}$ = 1 $\Omega$		45	68		
Fall Time	t <sub>f</sub>			27	41		
Turn-On Delay Time	t <sub>d(on)</sub>			18	30	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 15 V, $R_L$ = 1.5 $\Omega$		15	25		
Turn-Off Delay Time	t <sub>d(off)</sub>	$\text{I}_{\text{D}}\cong$ - 10 A, $\text{V}_{\text{GEN}}$ = - 10 V, $\text{R}_{\text{g}}$ = 1 $\Omega$		52	80		
Fall Time	t <sub>f</sub>			14	25		
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	ا <sub>S</sub>	T <sub>C</sub> = 25 °C			- 5.8	۸	
Pulse Diode Forward Current	I <sub>SM</sub>				- 60	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 10 A, V <sub>GS</sub> = 0 V		- 0.78	- 1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			35	53	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			25	38	nC	
Reverse Recovery Fall Time	ta	I <sub>F</sub> = - 10 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		19			
Reverse Recovery Rise Time	t <sub>b</sub>			16		ns	

Notes:

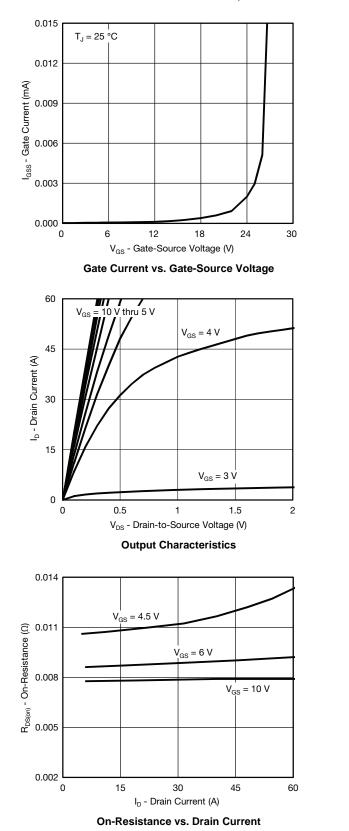
a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%$ 

b. Guaranteed by design, not subject to production testing.

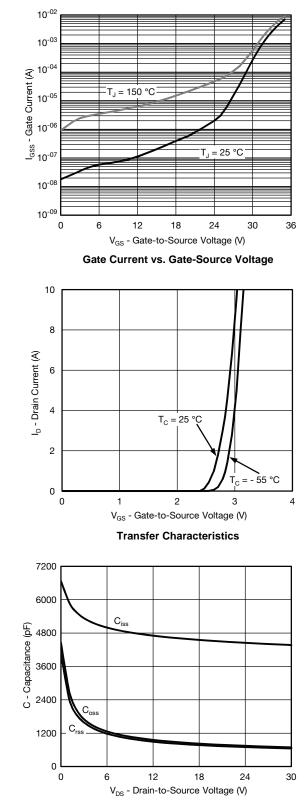
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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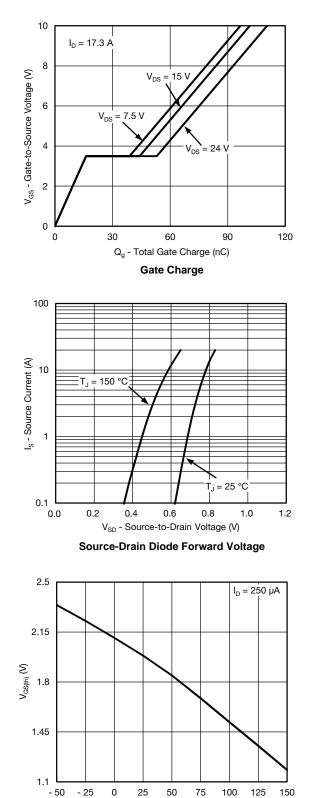


#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



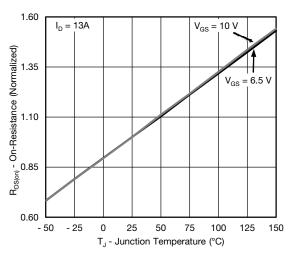
Capacitance



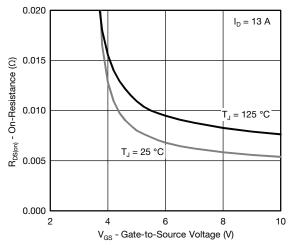


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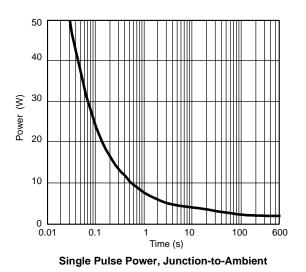
T<sub>J</sub> - Temperature (°C) Threshold Voltage



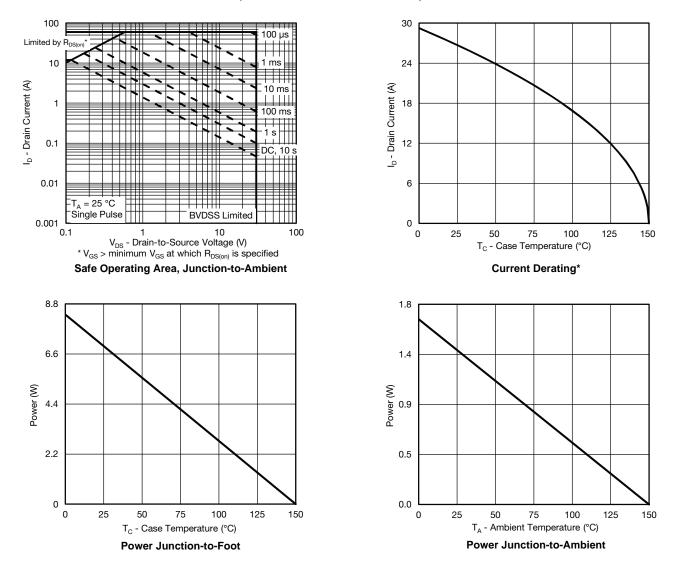
**On-Resistance vs. Junction Temperature** 



On-Resistance vs. Gate-to-Source Voltage







#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

\* The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



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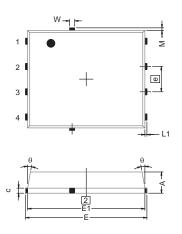
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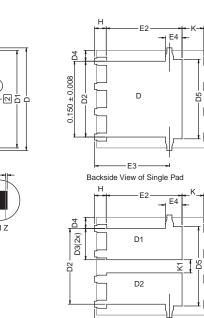
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### PowerPAK SO-8, (SINGLE/DUAL)





Notes

1. Inch will govern.

2 Dimensions exclusive of mold gate burrs.

3. Dimensions exclusive of mold flash and cutting burrs.

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Detail Z

⊨\_\_\_\_E3 → Backside View of Dual Pad

	MILLIMETERS			INCHES			
DIM.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
А	0.97	1.04	1.12	0.038	0.041	0.044	
A1	0.00	-	0.05	0.000	-	0.002	
b	0.33	0.41	0.51	0.013	0.016	0.020	
С	0.23	0.28	0.33	0.009	0.011	0.013	
D	5.05	5.15	5.26	0.199	0.203	0.207	
D1	4.80	4.90	5.00	0.189	0.193	0.197	
D2	3.56	3.76	3.91	0.140	0.148	0.154	
D3	1.32	1.50	1.68	0.052	0.059	0.066	
D4	0.57 TYP.			0.0225 TYP.			
D5		3.98 TYP.			0.157 TYP.		
E	6.05	6.15	6.25	0.238	0.242	0.246	
E1	5.79	5.89	5.99	0.228	0.232	0.236	
E2	3.48	3.66	3.84	0.137	0.144	0.151	
E3	3.68	3.78	3.91	0.145	0.149	0.154	
E4		0.75 TYP.	•	0.030 TYP.			
е	1.27 BSC			0.050 BSC			
К		1.27 TYP.		0.050 TYP.			
K1	0.56	-	-	0.022	-	-	
Н	0.51	0.61	0.71	0.020	0.024	0.028	
L	0.51	0.61	0.71	0.020	0.024	0.028	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
θ	0°	-	12°	0°	-	12°	
W	0.15	0.25	0.36	0.006	0.010	0.014	
М	0.125 TYP.			0.005 TYP.			



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